## Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination PARTSCH, TORSTEN Examiner | Art Unit | Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,205,516	03-2001	Usami, Hajime	711/105
*	В	US-6,226,757	05-2001	Ware et al.	713/503
*	O	US-6,438,061	08-2002	Suyama et al.	365/227
*	D	US-6,151,270	11-2000	Jeong, Woo-Seop	365/233
*	Ε	US-5,553,256	09-1996	Fetterman et al.	712/217
*	F	US-5,829,016	10-1998	Sharma et al.	711/111
*	G	US-3,958,223	05-1976	Cochran, Michael J.	711/5
*	Н	US-3,593,286	07-1971	Altman, Norman G.	382/215
*	ı	US-6,469,474	10-2002	Bunker, M. Scott	320/132
*	J	US-5,923,613	07-1999	Tien et al.	365/233
*	К	US-6,434,082	08-2002	Hovis et al.	365/233
*	L	US-3,614,317	10-1971	Benowitz et al.	375/335
*	М	US-3,987,287	10-1976	Cox et al.	326/39

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	•				
	0					
	Р			,		
	Q					
	R					
	s					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
	U						
	V						
	w						
	×						

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.